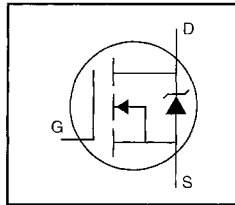


### HEXFET® Power MOSFET

- Dynamic  $dv/dt$  Rating
- Repetitive Avalanche Rated
- Logic-Level Gate Drive
- $R_{DS(on)}$  Specified at  $V_{GS}=4V$  &  $5V$
- $175^{\circ}C$  Operating Temperature
- Fast Switching
- Ease of Paralleling



$$V_{DSS} = 100V$$

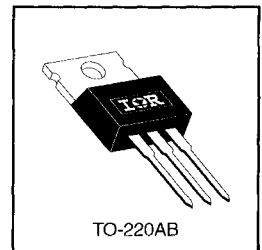
$$R_{DS(on)} = 0.27\Omega$$

$$I_D = 9.2A$$

### Description

Third Generation HEXFETs from International Rectifier provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.


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
### Absolute Maximum Ratings

|                              | Parameter  | Max.                  | Units          |
|------------------------------|--|-----------------------|----------------|
| $I_D$ @ $T_C = 25^{\circ}C$  | Continuous Drain Current, $V_{GS}$ @ 5.0 V       | 9.2                   | A              |
| $I_D$ @ $T_C = 100^{\circ}C$ | Continuous Drain Current, $V_{GS}$ @ 5.0 V       | 6.5                   |                |
| $I_{DM}$                     | Pulsed Drain Current ①                           | 36                    |                |
| $P_D$ @ $T_C = 25^{\circ}C$  | Power Dissipation                                | 60                    | W              |
|                              | Linear Derating Factor                           | 0.40                  | W/ $^{\circ}C$ |
| $V_{GS}$                     | Gate-to-Source Voltage                           | $\pm 10$              | V              |
| $E_{AS}$                     | Single Pulse Avalanche Energy ②                  | 170                   | mJ             |
| $I_{AR}$                     | Avalanche Current ①                              | 9.2                   | A              |
| $E_{AR}$                     | Repetitive Avalanche Energy ①                    | 6.0                   | mJ             |
| $dv/dt$                      | Peak Diode Recovery $dv/dt$ ③                    | 5.5                   | V/ns           |
| $T_J$<br>$T_{STG}$           | Operating Junction and Storage Temperature Range | -55 to +175           | $^{\circ}C$    |
|                              | Soldering Temperature, for 10 seconds            | 300 (1.6mm from case) |                |
|                              | Mounting Torque, 6-32 or M3 screw                | 10 lbf•in (1.1 N•m)   |                |


### Thermal Resistance

|                 | Parameter                           | Min. | Typ. | Max. | Units         |
|-----------------|-------------------------------------|------|------|------|---------------|
| $R_{\theta JC}$ | Junction-to-Case                    | —    | —    | 2.5  | $^{\circ}C/W$ |
| $R_{\theta CS}$ | Case-to-Sink, Flat, Greased Surface | —    | 0.50 | —    |               |
| $R_{\theta JA}$ | Junction-to-Ambient                 | —    | —    | 62   |               |

## Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

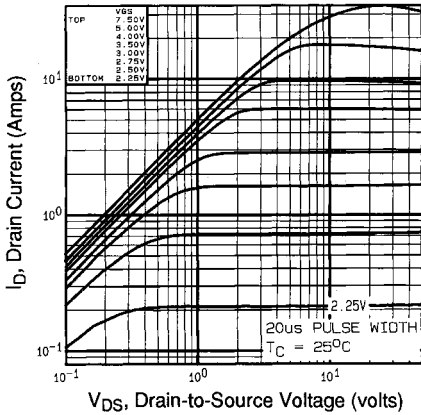
|                                 | Parameter                            | Min. | Typ. | Max. | Units              | Test Conditions  |
|---------------------------------|--------------------------------------|------|------|------|--------------------|--|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 100  | —    | —    | V                  | $V_{GS}=0V, I_D=250\mu A$  |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 0.12 | —    | $V/^\circ\text{C}$ | Reference to $25^\circ\text{C}, I_D=1\text{mA}$  |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | —    | 0.27 | $\Omega$           | $V_{GS}=5.0V, I_D=5.5A$ ④  |
|                                 |                                      | —    | —    | 0.38 |                    | $V_{GS}=4.0V, I_D=4.6A$ ④  |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 1.0  | —    | 2.0  | V                  | $V_{DS}=V_{GS}, I_D=250\mu A$  |
| $g_{fs}$                        | Forward Transconductance             | 3.2  | —    | —    | S                  | $V_{DS}=50V, I_D=5.5A$ ④   |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —    | 25   | $\mu A$            | $V_{DS}=100V, V_{GS}=0V$   |
|                                 |                                      | —    | —    | 250  |                    | $V_{DS}=80V, V_{GS}=0V, T_J=150^\circ\text{C}$   |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —    | 100  | nA                 | $V_{GS}=10V$   |
|                                 | Gate-to-Source Reverse Leakage       | —    | —    | -100 |                    | $V_{GS}=-10V$  |
| $Q_g$                           | Total Gate Charge                    | —    | —    | 12   | nC                 | $I_D=9.2A$   |
| $Q_{gs}$                        | Gate-to-Source Charge                | —    | —    | 3.0  |                    | $V_{DS}=80V$   |
| $Q_{gd}$                        | Gate-to-Drain ("Miller") Charge      | —    | —    | 7.1  |                    | $V_{GS}=5.0V$ See Fig. 6 and 13 ④  |
| $t_{d(on)}$                     | Turn-On Delay Time                   | —    | 9.8  | —    | ns                 | $V_{DD}=50V$   |
| $t_r$                           | Rise Time                            | —    | 64   | —    |                    | $I_D=9.2A$   |
| $t_{d(off)}$                    | Turn-Off Delay Time                  | —    | 21   | —    |                    | $R_G=9.0\Omega$  |
| $t_f$                           | Fall Time                            | —    | 27   | —    |                    | $R_D=5.2\Omega$ See Figure 10 ④  |
| $L_D$                           | Internal Drain Inductance            | —    | 4.5  | —    | nH                 | Between lead, 6 mm (0.25in.) from package and center of die contact  |
| $L_S$                           | Internal Source Inductance           | —    | 7.5  | —    |                    |  |
| $C_{iss}$                       | Input Capacitance                    | —    | 490  | —    | pF                 | $V_{GS}=0V$  |
| $C_{oss}$                       | Output Capacitance                   | —    | 150  | —    |                    | $V_{DS}=25V$   |
| $C_{rss}$                       | Reverse Transfer Capacitance         | —    | 30   | —    |                    | $f=1.0\text{MHz}$ See Figure 5   |

## Source-Drain Ratings and Characteristics

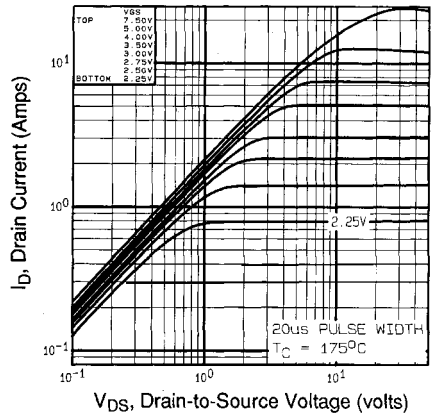
|          | Parameter                              | Min.  | Typ. | Max. | Units         | Test Conditions   |
|----------|--|---|------|------|---------------|---|
| $I_S$    | Continuous Source Current (Body Diode) | —   | —    | 9.2  | A             | MOSFET symbol showing the integral reverse p-n junction diode.  |
| $I_{SM}$ | Pulsed Source Current (Body Diode) ①   | —   | —    | 36   |               |   |
| $V_{SD}$ | Diode Forward Voltage                  | —   | —    | 2.5  | V             | $T_J=25^\circ\text{C}, I_S=9.2A, V_{GS}=0V$ ④   |
| $t_{rr}$ | Reverse Recovery Time                  | —   | 130  | 190  | ns            | $T_J=25^\circ\text{C}, I_F=9.2A$  |
| $Q_{rr}$ | Reverse Recovery Charge                | —   | 0.83 | 1.0  | $\mu\text{C}$ | $di/dt=100A/\mu\text{s}$ ④  |
| $t_{on}$ | Forward Turn-On Time                   | Intrinsic turn-on time is negligible (turn-on is dominated by $L_S+L_D$ ) |      |      |               |   |

### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature (See Figure 11)
- ②  $V_{DD}=25V$ , starting  $T_J=25^\circ\text{C}$ ,  $L=3.0\text{mH}$ ,  $R_G=25\Omega$ ,  $I_{AS}=9.2A$  (See Figure 12)
- ③  $I_{SD}\leq 9.2A$ ,  $di/dt\leq 110A/\mu\text{s}$ ,  $V_{DD}\leq V_{(BR)DSS}$ ,  $T_J\leq 175^\circ\text{C}$
- ④ Pulse width  $\leq 300\mu\text{s}$ ; duty cycle  $\leq 2\%$ .

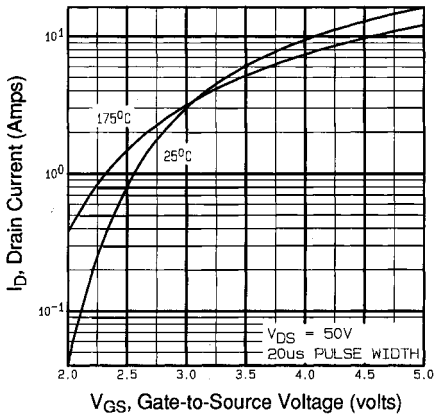


**Fig 1.** Typical Output Characteristics,  
 $T_C=25^\circ\text{C}$

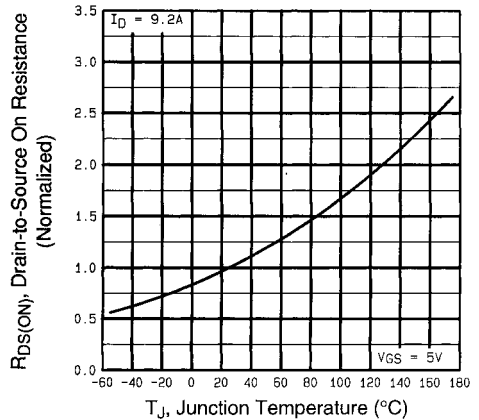


**Fig 2.** Typical Output Characteristics,  
 $T_C=175^\circ\text{C}$

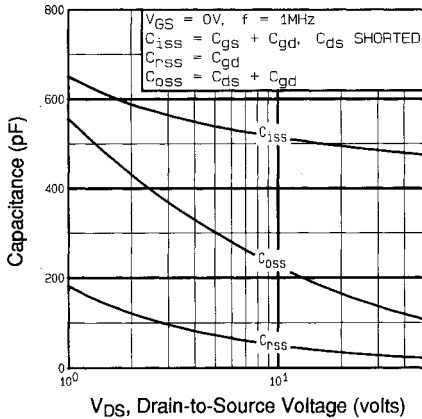
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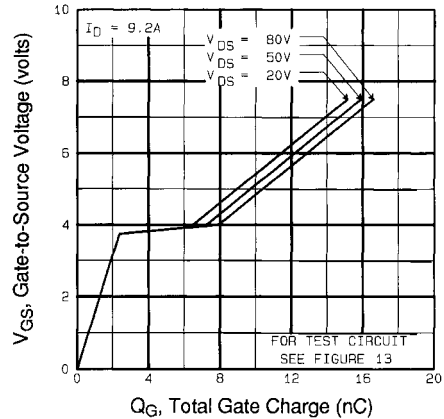
**Fig 3.** Typical Transfer Characteristics



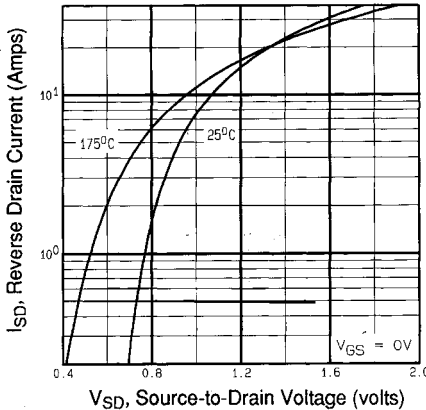
**Fig 4.** Normalized On-Resistance  
Vs. Temperature



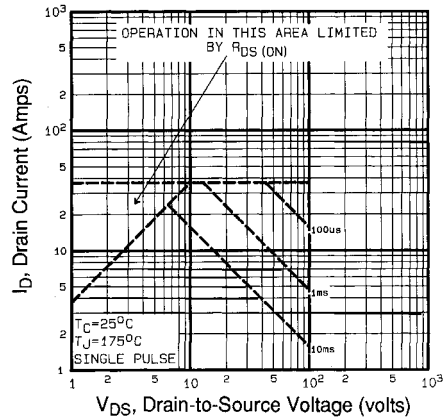
**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage



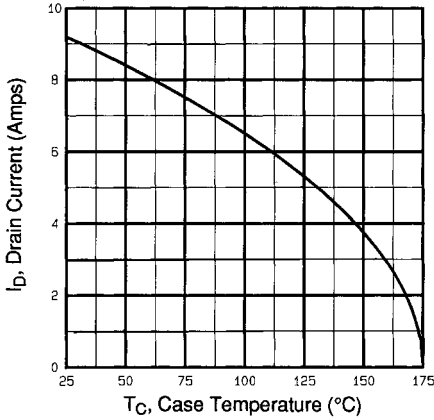
**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage



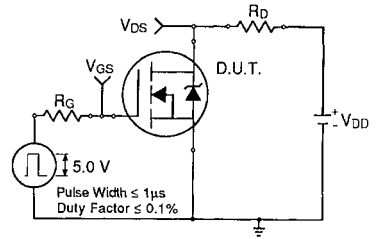
**Fig 7.** Typical Source-Drain Diode Forward Voltage



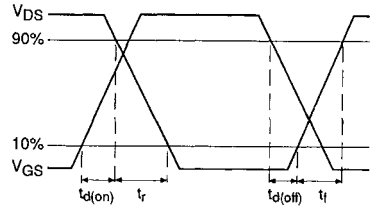
**Fig 8.** Maximum Safe Operating Area



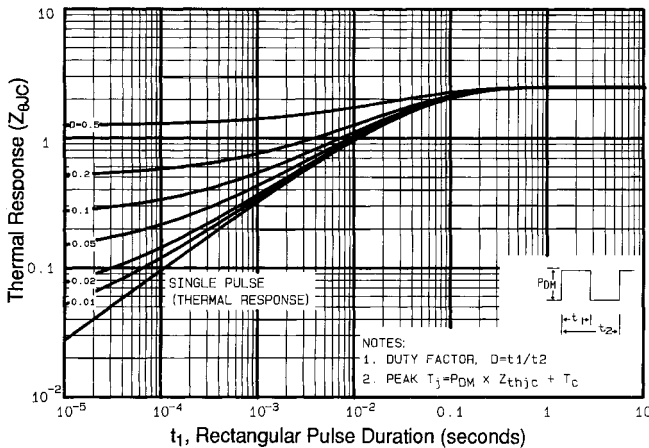
**Fig 9.** Maximum Drain Current Vs. Case Temperature



**Fig 10a.** Switching Time Test Circuit

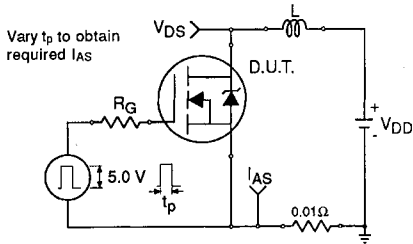


**Fig 10b.** Switching Time Waveforms

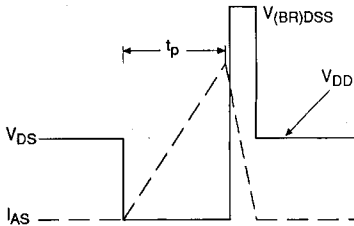


**Fig 11.** Maximum Effective Transient Thermal Impedance, Junction-to-Case

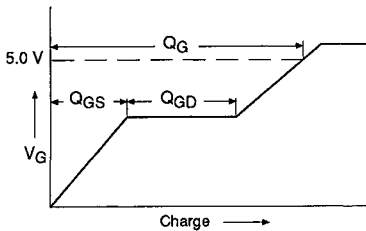
DATA SHEETS



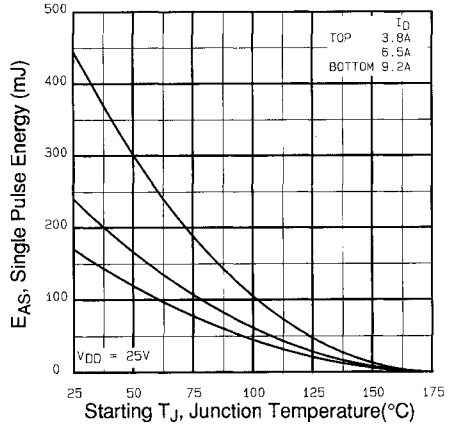
**Fig 12a.** Unclamped Inductive Test Circuit



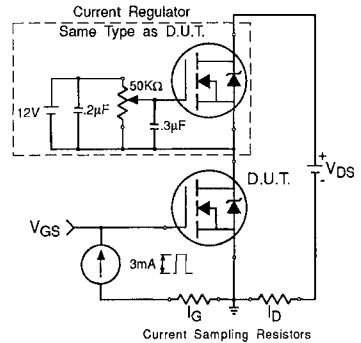
**Fig 12b.** Unclamped Inductive Waveforms



**Fig 13a.** Basic Gate Charge Waveform



**Fig 13c.** Maximum Avalanche Energy Vs. Drain Current



**Fig 13b.** Gate Charge Test Circuit

**Appendix A:** Figure 14, Peak Diode Recovery  $dv/dt$  Test Circuit – See page 1505

**Appendix B:** Package Outline Mechanical Drawing – See page 1509

**Appendix C:** Part Marking Information – See page 1516

**Appendix E:** Optional Leadforms – See page 1525